IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Ap	plication of: KEVIN R. LENSING	§ §	
Serial No.: Unknown		§ § §	Examiner: Unknown Group Art Unit: Unknown
Filed:	Concurrently Herewith	8 8 8	Att'y Docket: 2000.071900/TT4369
For:	METHOD OF USING SCATTEROMETRY MEASUREMENTS TO CONTROL PHOTORESIST ETCH PROCESS	§ § §	

POWER OF ATTORNEY

Assistant Commissioner for Patents Washington, D.C. 20231

Sir:

The undersigned, being the inventor named in the above-identified application, hereby revokes any previous Powers of Attorney and appoints:

Elizabeth A. Apperley, Reg. No. 36,428; Bradley Botsch, Reg. No. 34,552; Michael Caywood, Reg. No. 37,797; Daniel R. Collopy, Reg. No. 33,667; Paul S. Drake, Reg. No. 33,491; Rajendra Jaipershad, Reg. No. 44,168; Richard J. Roddy, Reg. No. 27,688; and Harry A. Wolin, Reg. No. 32,638 of Advanced Micro Devices, Inc.; and

Danny L. Williams, Reg. No. 31,892; Terry D. Morgan, Reg. No. 31,181; J. Mike Amerson, Reg. No. 35,426; Kenneth D. Goodman, Reg. No. 30,460; Jeffrey A. Pyle, Reg. No. 34,904; Randall C. Furlong, Reg. No. 35,144; Scott F. Diring, Reg. No. 35,119; George J. Oehling, Reg. No. 40,471; Shelley P.M. Fussey, Reg. No. 39,458; Mark D. Moore, Reg. No. 42,903; Louis H. Iselin, Reg. No. 42,684; Raymund F. Eich, Reg. No. 42,508; Bradley A. Misley, Reg. No. 46,937; Thomas H. Belvin, Jr., Reg. No. 43,491; Daren C. Davis, Reg. No. 38,425; and Stephanie A. Wardwell, Reg. No. 48,025 of Williams, Morgan & Amerson, P.C.,

as its attorney or agent so long as they remain with such firms, with full power of substitution and revocation, to prosecute the application, to make alterations and amendments therein, to transact all business in the Patent and Trademark Office in connection therewith, and to receive any Letters Patent, and for one year after issuance of such Letters Patent to file any request for a certificate of correction that may be deemed appropriate.

Please direct all communications as follows:

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Signature: Kuhn	Date: 6/25/01
KEVIN'R, LENSING	

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DECLARATION

As a below named inventor, I hereby declare that:

My residence, post office address and citizenship are as stated below next to my name.

I believe I am the original, first and sole inventor (if only one name is listed below) or the below named inventors are the original, first and joint inventors (if plural names are listed below) of the subject matter which is claimed and for which a patent is sought on the invention entitled "METHOD OF USING SCATTEROMETRY MEASUREMENTS TO CONTROL PHOTORESIST ETCH PROCESS" the Specification of which:

	ed hereto.		
was filed	on as Ap	plication Serial No	
I hereby state the including the claims.	at I have reviewed an	d understand the contents of	the above-identified specification,
I acknowledge the material to patentability of of Federal Regulations, § 1		e Patent and Trademark Office ned in this application, as "mate	all information known to me to be riality" is defined in Title 37, Code
I hereby claim pri patent, United States provi any foreign application for before that of the application	patent, United States or	ovisional application or investigation	19 of any foreign application(s) for low and have also identified below tor's certificate having a filing date
	PRIORITY APPI	LICATION(S)	Priority Claimed
(Number)	(Country)	(Date Filed)	Yes/No
(Number)	(Country)	(Date Filed)	Yes/No
United States application ir acknowledge the duty to disclaimed in this application,	the manner provided in the manner provided in the manner provided in the sclose all information k	by the first paragraph of Title nown to me to be material to paragraph in Title 27. Code as Fig.	f any United States application(s) ation is not disclosed in the prior 35, United States Code, § 112, I patentability of the subject matter leral Regulations, § 1.56, which or PCT international filing date of
(Application Serial	No.) (Filing Da	te) (Status)	
(Application Serial	No.) (Filing Da	te) (Status)	
I hereby direct that Morgan & Amerson, P.C., 76	all correspondence and	telephone calls be addressed	to J. Mike Amerson, Williams,

Morgan & Amerson, P.C., 7676 Hillmont, Suite 250, Houston, Texas 77040, (713) 934-4055.

I HEREBY DECLARE THAT ALL STATEMENTS MADE OF MY OWN KNOWLEDGE ARE TRUE AND THAT ALL STATEMENTS MADE ON INFORMATION AND BELIEF ARE BELIEVED TO BE TRUE; AND FURTHER THAT THESE STATEMENTS WERE MADE WITH THE KNOWLEDGE THAT WILLFUL FALSE STATEMENTS AND THE LIKE SO MADE ARE PUNISHABLE BY FINE OR IMPRISONMENT, OR BOTH, UNDER SECTION 1001 OF TITLE 18 OF THE UNITED STATES CODE AND THAT SUCH WILLFUL FALSE STATEMENTS MAY JEOPARDIZE THE VALIDITY OF THE APPLICATION OR ANY PATENT ISSUED THEREON.

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